

Search Notes



Application/Control No.

10/605,427

Examiner

Henry K. Choe

Applicant(s)/Patent under Reexamination

YEH, EN-HSIANG

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	252	3/27/05 H.C.	
"	254	"	"
"	260	"	"
"	261	3/28/05	"
327	359	"	"

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Term search (East)	3/28/05 H.C.	
NPL (IEEE)	"	"